

# CLC5956

## 12-bit, 65 MSPS Broadband Monolithic A/D Converter

### General Description

The CLC5956 is a monolithic 12-bit, 65 MSPS analog-to-digital converter subsystem. The device has been optimized for use in cellular base stations and other applications where high resolution, high sampling rate, wide dynamic range, low power dissipation, and compact size are required. The CLC5956 features differential analog inputs, low jitter differential PECL clock inputs, a low distortion track-and-hold with DC to 300 MHz input bandwidth, a band-gap voltage reference, TTL compatible CMOS output logic, and a proprietary 12-bit multi-stage quantizer. The CLC5956 is fabricated on the ABIC-IV 0.8 micron BiCMOS process. The part features a 73 dB spurious free dynamic range (SFDR) and 67 dB SNR. The wideband track-and-hold allows sampling of IF signals to greater than 250 MHz. The part produces two-tone, dithered, spurious-free dynamic range of 83 dBFS at 75 MHz input frequency. The differential analog input provides excellent common-mode rejection, while the differential PECL clock inputs permit the use of balanced transmission to minimize jitter in distributed systems. The 48-pin TSSOP package provides an extremely small footprint for applications where space is a critical consideration. The CLC5956 operates from a single +5V power supply over the industrial temperature range of  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ . National thoroughly tests each part to verify full compliance with the guaranteed specifications.

### Features

- Wide dynamic range
- IF sampling capability
- 300 MHz input bandwidth
- Small 48-pin TSSOP
- Single +5V supply
- Low cost

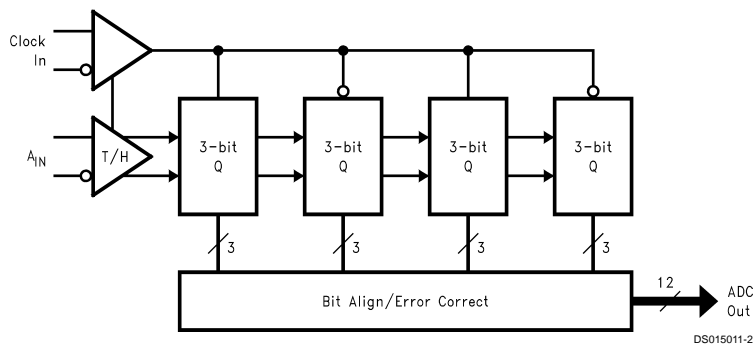
### Key Specifications

■ Sample Rate	65 MSPS
■ SFDR	73 dBc
■ SFDR with dither	85 dBFS
■ SNR	67 dB
■ Low power consumption	615 mW

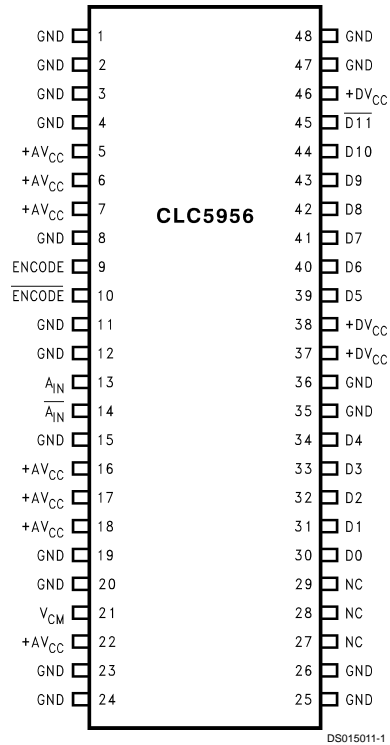
### Applications

- Cellular base-stations
- Digital communications
- Infrared/CCD imaging
- IF sampling
- Electro-optics
- Instrumentation
- Medical imaging
- High definition video

### Block Diagram



## Pin Configuration



## Ordering Information

CLC5956IMTD	48-Pin TSSOP
CLC5956IMTDX	48-Pin TSSOP (Taped Reel)
CLC5956PCASM	Evaluation Board

## Pin Descriptions

Pin Name	Pin No.	Description
$\frac{A_{IN}}{A_{IN}}$	13, 14	Differential input with a common mode voltage of +2.4V. The ADC full scale input is 1.024 V <sub>PP</sub> on each of the complimentary input signals.
ENCODE ENCODE	9, 10	Differential clock where ENCODE initiates a new data conversion cycle on each rising edge. Logic for these inputs are a 50% duty cycle differential PECL signal.
VCM	21	Internal common mode voltage reference. Nominally +2.4V. Can be used for the input common mode voltage. This voltage is derived from an internal bandgap reference.
D0– $\overline{D11}$	30–34, 39–45	Digital data outputs are CMOS and TTL compatible. D0 is the LSB and $\overline{D11}$ is the MSB. MSB is inverted. Output coding is two's complement.
GND	1–4, 8, 11, 12, 15, 19, 20, 23–26, 35, 36, 47, 48	Circuit ground.
+AV <sub>CC</sub>	5–7, 16–18, 22	+5V power supply for the analog section. Bypass to ground with a 0.1 μF capacitor.
+DV <sub>CC</sub>	37, 38, 46	+5V power supply for the digital section. Bypass to ground with a 0.1 μF capacitor.

## Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Positive Supply Voltage ( $V_{CC}$ )	-0.5V to +6V
Differential Voltage between any Two Grounds	<200 mV
Analog Input Voltage Range	GND to $V_{CC}$
Digital Input Voltage Range	-0.5V to + $V_{CC}$
Output Short Circuit Duration (one-pin to ground)	Infinite
Junction Temperature (Note 6)	175°C
Storage Temperature Range	-65°C to +150°C
Lead Solder Duration (+300°C)	10 sec.

## Recommended Operating Conditions

Positive Supply Voltage ( $V_{CC}$ )	+5V ±5%
Analog Input Voltage Range	2.048 $V_{PP}$ diff.
Operating Temperature Range	-40°C to +85°C

## Package Thermal Resistance (Note 6)

<b>Package</b>	$\theta_{JA}$	$\theta_{JC}$
48-Pin TSSOP	56°C/W	16°C/W

## Reliability Information

Transistor Count	5000
------------------	------

## Converter Electrical Characteristics

The following specifications apply for  $AV_{CC} = DV_{CC} = +5V$ , 52 MSPS, 50% Encode Clock Duty Cycle,  $C_L = 7$  pF. **Boldface limits apply for  $T_A = T_{min} = -40^\circ C$  to  $T_{max} = +85^\circ C$ , all other limits  $T_A = 25^\circ C$  (Notes 2, 3, 4).**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>DYNAMIC PERFORMANCE</b>						
BW	Large-Signal Bandwidth	$V_{IN} = FS -3$ dB		300		MHz
	Overshoot Recovery Time	$V_{IN} = 1.5$ FS (0.01%)		12		ns
$t_{DS}$	Effective Aperture Delay			-0.21		ns
$t_{AJ}$	Aperture Jitter			0.4		ps(rms)
<b>NOISE AND DISTORTION</b>						
SNR	Signal-to-Noise Ratio (without harmonics)	$f_{IN} = 20$ MHz, FS -1 dB	63	66		dBFS
		$f_{IN} = 5$ MHz, FS -3 dB		67		dBFS
		$f_{IN} = 25$ MHz, FS -3 dB		66		dBFS
		$f_{IN} = 75$ MHz, FS -3 dB		64		dBFS
		$f_{IN} = 150$ MHz, FS -3 dB		62		dBFS
		$f_{IN} = 250$ MHz, FS -3 dB		59		dBFS
SFDR	Spurious-Free Dynamic Range	$f_{IN} = 20$ MHz, FS -1 dB	66	70		dBc
		$f_{IN} = 5$ MHz, FS -3 dB		73		dBc
		$f_{IN} = 25$ MHz, FS -3 dB		70		dBc
		$f_{IN} = 75$ MHz, FS -3 dB		68		dBc
		$f_{IN} = 150$ MHz, FS -3 dB		58		dBc
		$f_{IN} = 250$ MHz, FS -3 dB		55		dBc
	Spurious-Free Dynamic Range (dithered)	$f_{IN} = 19$ MHz, FS -6 dB		85		dBFS
IMD	Intermodulation Distortion	$f_1 = 149.84$ MHz, $f_2 = 149.7$ MHz, FS -10 dB		68		dBFS
		$f_1 = 249.86$ MHz, $f_2 = 249.69$ MHz, FS -10 dB		58		dBFS
	Intermodulation Distortion (dithered)	$f_1 = 74$ MHz, $f_2 = 75$ MHz, FS -12 dB		83		dBFS
<b>DC ACCURACY AND PERFORMANCE</b>						
DNL	Differential Non-Linearity	DC; Full Scale		0.65		LSB
INL	Integral Non-Linearity	DC; Full Scale		1.7		LSB
	Bipolar Offset Error			-1		mV
	Bipolar Gain Error			-0.1		% FS
<b>ANALOG INPUTS</b>						
$V_{IN}$	Analog Diff Input Voltage Range			2.048		$V_{PP}$
$R_{IN}$ (SE)	Analog Input Resistance (Single-Ended)			500		$\Omega$

## Converter Electrical Characteristics (Continued)

The following specifications apply for  $AV_{CC} = DV_{CC} = +5V$ , 52 MSPS, 50% Encode Clock Duty Cycle,  $C_L = 7$  pF. **Boldface limits apply for  $T_A = T_{min} = -40^\circ C$  to  $T_{max} = +85^\circ C$** , all other limits  $T_A = 25^\circ C$  (Notes 2, 3, 4).

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>ANALOG INPUTS</b>						
$R_{IN}$ (Diff)	Analog Input Resistance (Differential)			1000		$\Omega$
$C_{IN}$	Analog Input Capacitance			2		pF
<b>ENCODE INPUTS</b>						
$V_{IL}$	Logic Input Low Voltage		<b>3.0</b>		<b>3.5</b>	V
$V_{IH}$	Logic Input High Voltage		<b>4.0</b>		<b>4.5</b>	V
$I_{IL}$	Logic Input Low Current			1	<b>5</b>	$\mu A$
$I_{IH}$	Logic Input High Current			16	<b>25</b>	$\mu A$
<b>DIGITAL OUTPUTS</b>						
$V_{OL}$	Logic Output Low Voltage				<b>0.4</b>	V
$V_{OH}$	Logic Output High Voltage		<b>2.4</b>			V
<b>TIMING</b>						
$F_{s,max}$	Maximum Conversion Rate			65		MSPS
$F_{s,min}$	Minimum Conversion Rate			10		MSPS
PWH	Pulse Width High			7.7		ns
PWL	Pulse Width Low			7.7		ns
	Pipeline Delay (Note 5)				<b>3.0</b>	CLK Cy
	Output Propagation Delay			1.6		ns
<b>POWER REQUIREMENTS</b>						
$I_{CC}$	Total Operating Supply Current	65 MSPS		123	150	mA
	Power Consumption	65 MSPS		615	750	mW
	Power Supply Rejection Ratio			64		dB

**Note 1:** "Absolute Maximum Ratings" are limiting values, to be applied individually, and beyond which the serviceability of the circuit may be impaired. Functional operability under any of these conditions is not necessarily implied. Exposure to maximum ratings for extended periods may affect device reliability.

**Note 2:** Limits are 100% tested at  $25^\circ C$ .

**Note 3:** Typical characteristics are the mean values of the distributions of deliverable converters at  $25^\circ C$ .

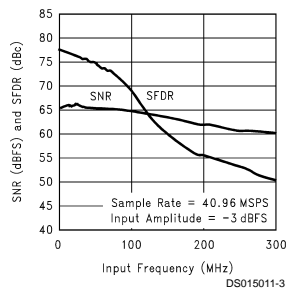
**Note 4:** Outgoing quality levels are determined from tested parameters.

**Note 5:** Max pipeline delay rating is based upon product characterization and simulation.

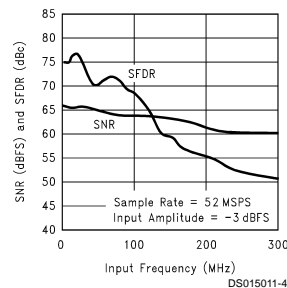
**Note 6:** The absolute maximum junction ( $T_{J,max}$ ) temperature for this device is  $175^\circ C$ . The maximum allowable power dissipation is dictated by  $T_{J,max}$ , the junction-to-ambient thermal resistance ( $\theta_{JA}$ ), and the ambient temperature ( $T_A$ ), and can be calculated using the formula  $P_{D,max} = (T_{J,max} - T_A)/\theta_{JA}$ . For the 48-pin TSSOP,  $\theta_{JA}$  is  $56^\circ C/W$ , so  $P_{D,max} = 2.68W$  at  $25^\circ C$  and  $1.6W$  at the maximum operating ambient temperature of  $85^\circ C$ . Note that the power dissipation of this device under normal operation will typically be about 625 mW (615 mW quiescent power + 10 mW due to 1 TTL load on each digital output). The values of absolute maximum power dissipation will only be reached when the CLC5956 is operated in a severe fault condition (e.g., when input or output pins are driven beyond the power supply voltages, or the power supply polarity is reversed). Obviously, such conditions should always be avoided.

## Typical Performance Characteristics ( $AV_{CC} = DV_{CC} = +5V$ )

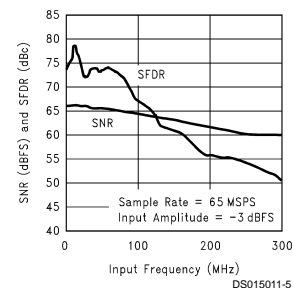
SNR and SFDR vs Input Frequency



SNR and SFDR vs Input Frequency

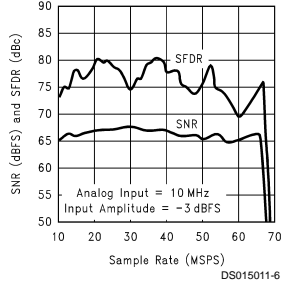


SNR and SFDR vs Input Frequency

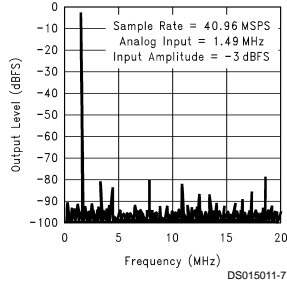


## Typical Performance Characteristics (AV<sub>CC</sub> = DV<sub>CC</sub> = +5V) (Continued)

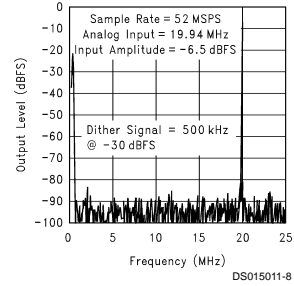
**SNR and SFDR vs Sample Rate**



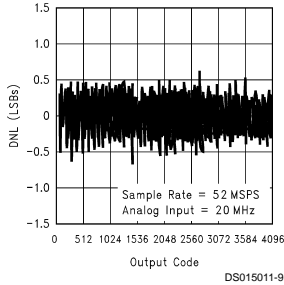
**Single Tone Output Spectrum**



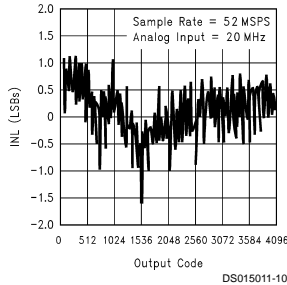
**Single Tone Output Spectrum (with Dither)**



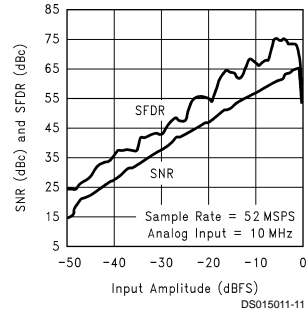
**Differential Non-Linearity**



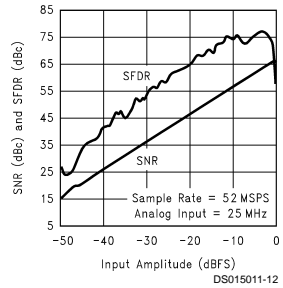
**Integral Non-Linearity**



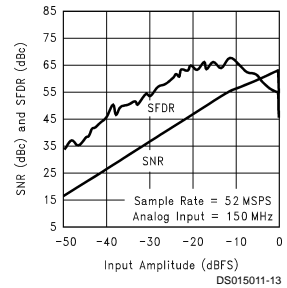
**SNR and SFDR vs Input Amplitude**



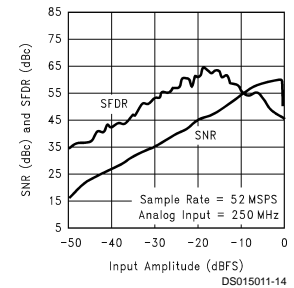
**SNR and SFDR vs Input Amplitude**



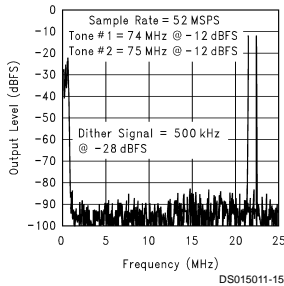
**SNR and SFDR vs Input Amplitude**



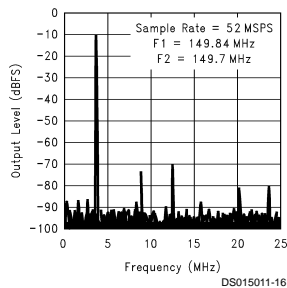
**SNR and SFDR vs Input Amplitude**



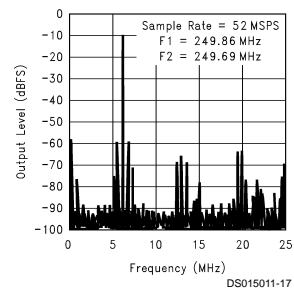
**Two Tone Output Spectrum (with Dither)**



**Two Tone Output Spectrum**

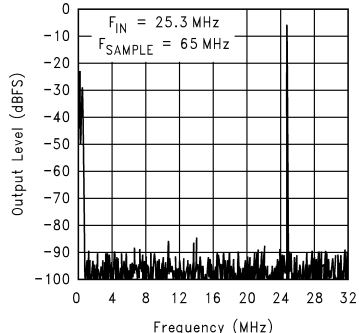


**Two Tone Output Spectrum**

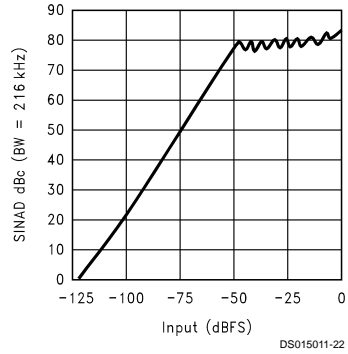


## Typical Performance Characteristics (AV<sub>CC</sub> = DV<sub>CC</sub> = +5V) (Continued)

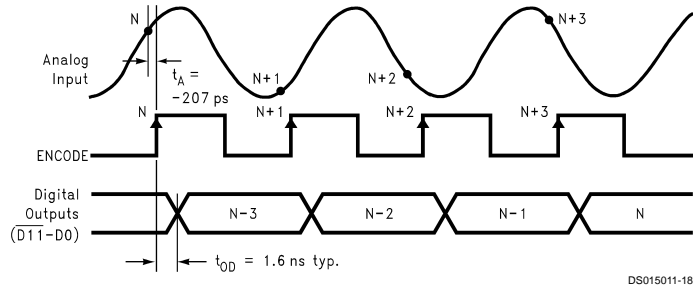
**Spectral Response**



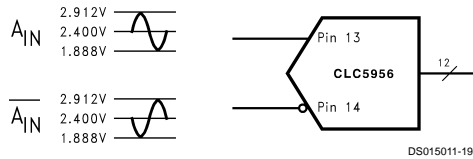
**SINAD vs Input Level**



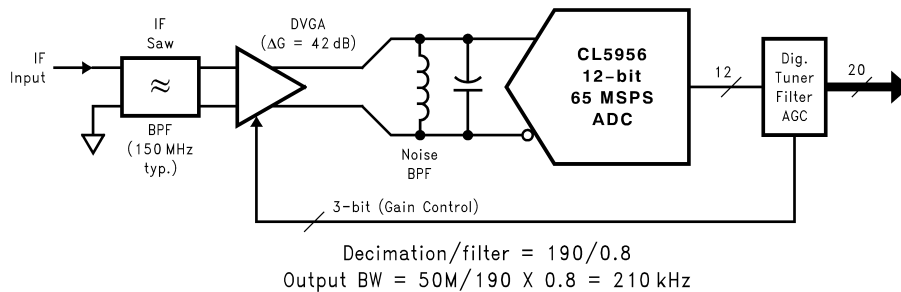
## Timing Diagram



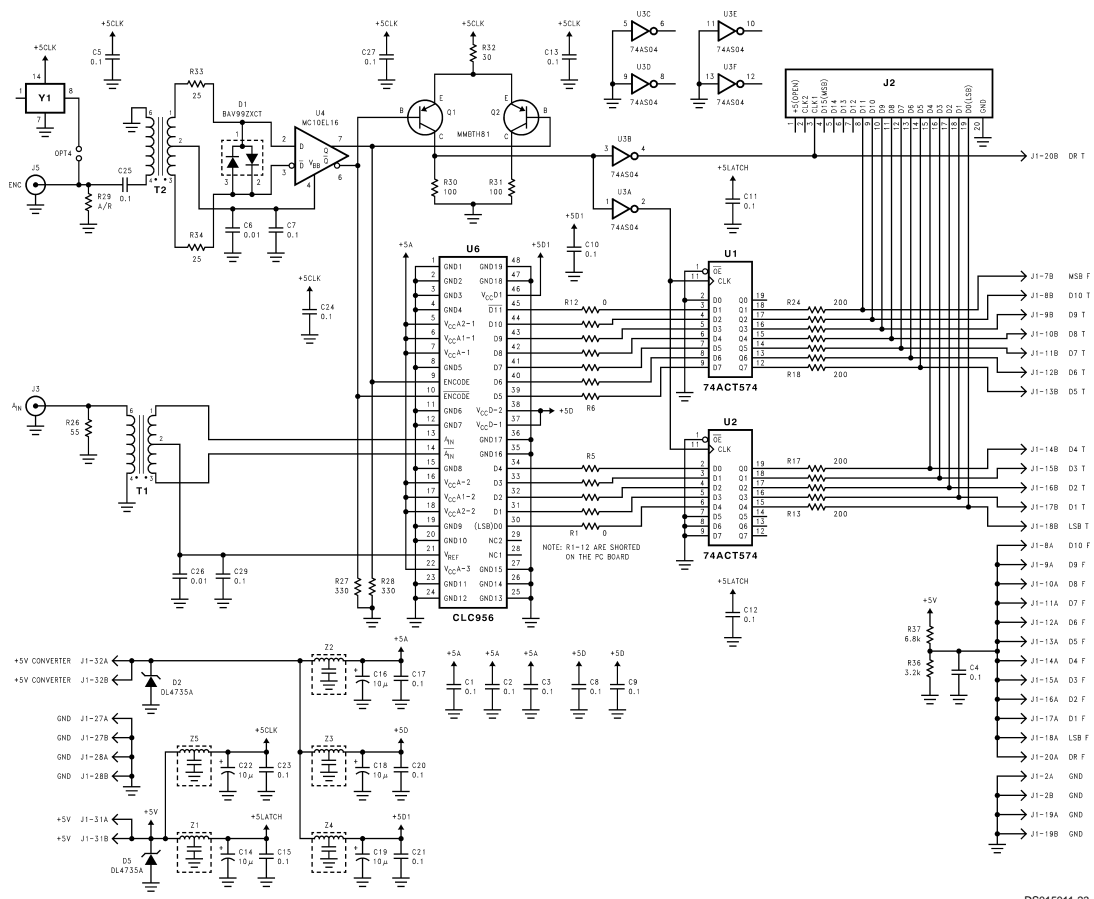
## Full Scale Analog Input Levels



## Single IF Down Converter



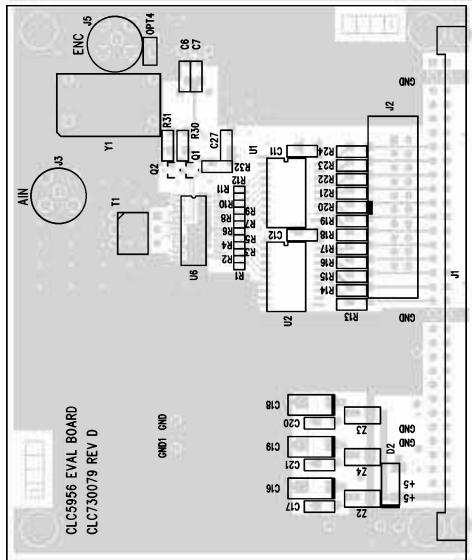
# Evaluation Board



DS015011-23

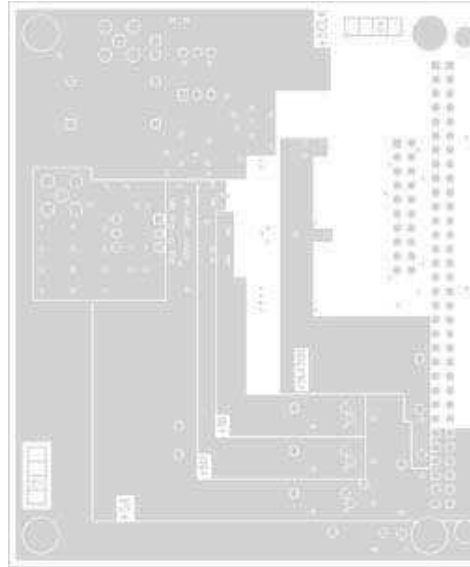
Evaluation Board Schematic

# Evaluation Board (Continued)



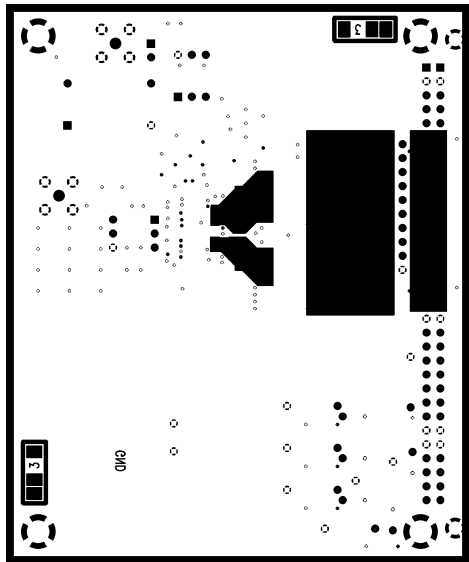
DS015011-24

CLC730079 Layer 1



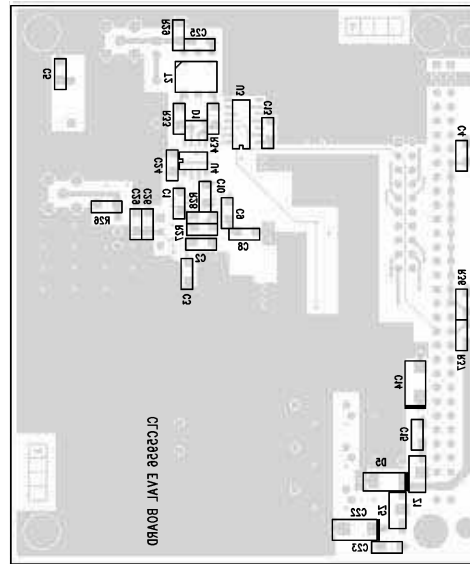
DS015011-26

CLC730079 Layer 2



DS015011-25

CLC730079 Layer 3



DS015011-27

CLC730079 Layer 4



## Evaluation Printed Circuit Board

The Evaluation board for the CLC5956 allows for easy test and evaluation of the product. The part may be ordered with all components loaded and tested. The order number is the CLC5956PCASM. The user supplies an analog input signal, encode signal and power to the board and is able to take latched 12-bit digital data out of the board.

### ENCODE Input (ENC)

The ENCODE input is an SMA connector with a 50Ω termination. The signal is converted from single to differential and its **frequency is divided by four** to produce a low jitter, symmetrical encode signal for the CLC5956. The user should provide a sinusoidal or square wave signal of 10 dBm to 16 dBm amplitude at **four times the converter's desired sample rate**. It is recommended that the source be low jitter to maintain best performance. The transformer will pass signals in the 40 MHz to 260 MHz range which allows sample rates of 10 Msps to 65 Msps.

### Clock Option

The CLC5956 board is configured for a 4x clock input to provide optimal performance with some (i.e., HP8662) synthesizers. The HP8662 output has lower jitter above 160 MHz. Using a 208 MHz clock to sample at 52 MHz minimizes the effect of the synthesizer on the measurement.

To use a 1x clock, replace the divide-by-4 sine-to-PECL converter (U4, MC10EL33D) with an MC10EL16D. The MC10EL16D sine-to-PECL converter does not divide the clock. This approach would be suitable for use with a synthesizer that has optimal jitter performance at 52 MHz (i.e., HP8643 or HP8644).

The best ADC performance is obtained with a low-jitter crystal oscillator module installed at Y1 on the evaluation board.

U4 should be replaced with an MC10EL16D. Placing the clock source on the evaluation board reduces ground loop issues and thus improves performance.

### Analog Input (AIN)

The analog input is an SMA connector with a 50Ω termination. The signal is converted from single to differential by a transformer with a 5 MHz to 260 MHz bandwidth and approximately one dB loss. Full scale is approximately 11 dBm or 2.2 V<sub>PP</sub>. It is recommended that the source for the analog input signal be low jitter, low noise and low distortion to allow for proper test and evaluation of the CLC5956.

### Supply Voltages (J1 pins 31 A&B and 32 A&B)

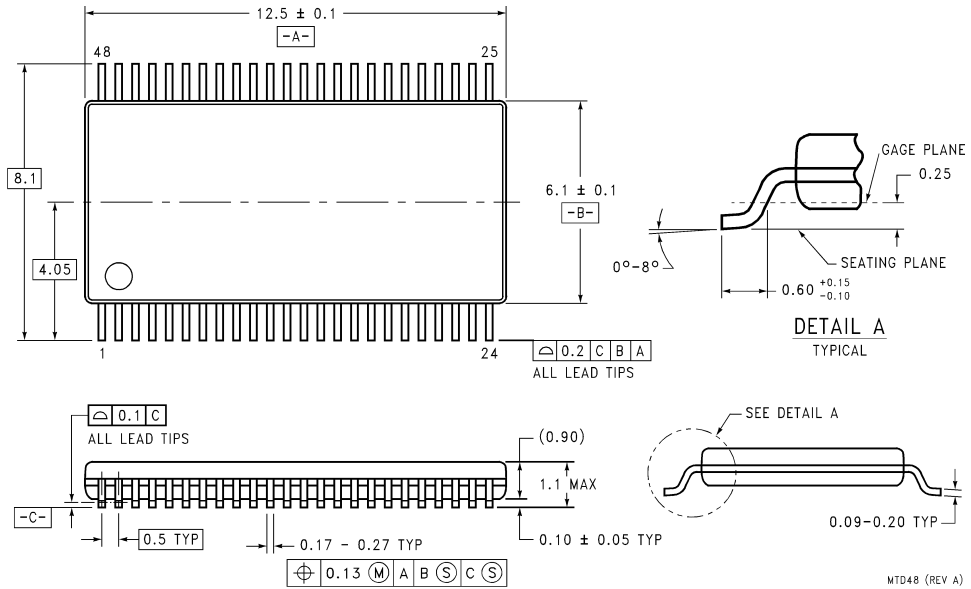
The CLC5956PCASM is powered from a single 5V supply connected from the referenced pins on the Eurocard connector. The recommended supplies are low noise linear supplies.

### Digital Outputs (J1 pins 7A (MSB, D11), 8B (D10) through 18B (LSB) and 20B (Data Ready))

The digital outputs are provided on the Eurocard connector. The outputs are buffered by 5V CMOS latches with 50Ω series output resistors. The rising edge of Data Ready may be used to clock the output data into data collection cards or logic analyzers. The board has a location for the HP 01650-63203 termination adapter for HP 16500 logic analyzers to simplify connection to the analyzer.

**CLC5956 12-bit, 65 MSPS Broadband Monolithic A/D Converter**

**Physical Dimensions** inches (millimeters) unless otherwise noted



**48-Lead TSSOP (Millimeters Only)**  
**Order Number CLC5956IMTD**  
**NS Package Number MTD48**

MTD48 (REV A)

**LIFE SUPPORT POLICY**

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT AND GENERAL COUNSEL OF NATIONAL SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.



**National Semiconductor Corporation**  
 Americas  
 Tel: 1-800-272-9959  
 Fax: 1-800-737-7018  
 Email: support@nsc.com

www.national.com

**National Semiconductor Europe**  
 Fax: +49 (0) 1 80-530 85 86  
 Email: europe.support@nsc.com  
 Deutsch Tel: +49 (0) 1 80-530 85 85  
 English Tel: +49 (0) 1 80-532 78 32  
 Français Tel: +49 (0) 1 80-532 93 58  
 Italiano Tel: +49 (0) 1 80-534 16 80

**National Semiconductor Asia Pacific Customer Response Group**  
 Tel: 65-2544466  
 Fax: 65-2504466  
 Email: sea.support@nsc.com

**National Semiconductor Japan Ltd.**  
 Tel: 81-3-5639-7560  
 Fax: 81-3-5639-7507

National does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and National reserves the right at any time without notice to change said circuitry and specifications.